19-Apr-2011 Rev A



### PCI Express Card Edge Connector, Vertical, DIP Type

### 1. INTRODUCTION

#### 1.1. PURPOSE

Testing was performed on the TE Connectivity PCI Express Card Edge Connector, Vertical, DIP Type to determine its conformance to the requirements of Product Specification 108-57871, Revision A.

#### 1.2. SCOPE

This report covers the electrical, mechanical, and environmental performance of the PCI Express Card Edge Connector, Vertical DIP Type.

#### 1.3. CONCLUSION

The PCI Express Card Edge Connector, Vertical, DIP Type listed in paragraph 1.5. conformed to the electrical, mechanical, and environmental performance requirements of Product Specification 108-57871, Revision A.

#### 1.4. PRODUCT DESCRIPTION

The PCI Express Card Edge connector is used in ATX or ATX-based systems, supporting x1, x4, x8, and x16 link widths to suit different bandwidth requirements. These connectors support the PCI Express signal and power requirements, as well as auxiliary signals used to facilitate the interface between motherboard and add-in card hardware.

#### 1.5. TEST SPECIMENS

Test specimens were representative of normal production lots. The following specimens were used for

Test Group	t Group Quantity Description		P/N		
A, B, C, D, E, F, G, H, I	PCI Express Card Edge Connector, Vertical, DIP Type		x-1734774-x		



1.6. QUALIFICATION TEST SEQUENCE

	Test Group									
Test or Examination	Α	В	С	D	Е	F	G (c)	H (c)	I	
	Test Sequence (a)									
Examination of product.	1, 9	1, 8	1, 10	1, 8	1, 8	1, 3	1, 3	1, 3	1, 3	
Low level contact resistance.	3, 7	2, 5, 7	2, 5, 7, 9	2, 5, 7						
Dielectric withstanding voltage.					2, 6					
Insulation resistance.					3, 7					
Mating force.	2, 6									
Unmating force.	4, 8									
Durability.	5	3	3	3						
Reseating.		6	8							
Vibration, random.				6 (b)						
Solderability.						2				
Resistance to wave soldering heat.							2			
Resistance to <b>reflow</b> soldering heat								2		
Temperature life.		4								
Temperature life (Preconditioning).				4						
Thermal shock.			4		4					
Humidity-temperature cycling.			6		5					
Contact current rating/ Temperature rise.									2	

# NOTE

- (a) Numbers indicate sequence in which test are performed.(b) Discontinuities shall not take place in this test group, during tests.(c) Resistance to soldering process is indicated on notes of customer drawing. Select the appropriate test type which drawing notes are matched with.

Figure 1

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# 2. TEST RESULT

Test	RESOLI			Test I			
Group	Test Description	Requirement	Max.	Min.	Ave.	Std. Dev.	Judgment
	Examination of product.	Meets product drawing.		PAS	Accepted		
А	Mating force.	117 g/contact pair max.	54.27 48.76 51.20 1.43			Accepted	
	Low level contact resistance.	30 mΩ max.	14.25	10.57	12.35	1.14	Accepted
	Unmating force.	15g/contact pair min.	24.26	18.34	21.50	1.73	Accepted
	Durability.	No damage.		PAS	SED		Accepted
	Mating force.	117g/contact pair max.	53.84	47.33	50.88	2.02	Accepted
	Low level contact resistance.	30 mΩ max.	18.57	14.38	16.84	1.08	Accepted
	Unmating Force.	15g/contact pair min.	22.69	18.24	20.14	1.37	Accepted
	Examination of product.	Meets product drawing.	PASSED				Accepted
	Examination of product.	Meets product drawing.	PASSED				Accepted
	Low level contact resistance.	30 mΩ max.	15.60	10.01	12.46	1.83	Accepted
	Durability.	No damage.		PAS	SED		Accepted
В	Temperature life.	No damage.		Accepted			
	Low level contact resistance	30 mΩ max.	20.15	14.57	16.97	1.27	Accepted
	Reseating.	No damage.		PAS	SED		Accepted
	Low level contact resistance.	30 mΩ max.	22.32	17.42	19.74	1.28	Accepted
	Examination of product.	Meets product drawing.		Accepted			
	Examination of product.	Meets product drawing.	PASSED			Accepted	
	Low level contact resistance.	30 mΩ Max.	15.34	9.58	12.25	1.42	Accepted
	Durability.	No damage.		PAS	SED		Accepted
	Thermal shock.	No damage.		PAS	SED		Accepted
С	Low level contact resistance.	30 mΩ Max.	18.37	14.02	16.21	1.17	Accepted
	Humidity-temperature cycling.	No damage.	PASSED			Accepted	
	Low level contact resistance.	30 mΩ max.	19.26	15.84	17.91	1.12	Accepted
	Reseating.	No damage.		PAS	SED		Accepted
	Low level contact resistance.	30 mΩ max.	22.54	17.75	20.59	1.49	Accepted
	Examination of product.	Meets product drawing.	PASSED				Accepted
D .	Examination of product.	Meets product drawing.		PAS	SED		Accepted
	Low level contact resistance.	30 mΩ Max.	15.01	9.15	11.53	1.54	Accepted
	Durability.	No damage.		PAS	SED		Accepted
	Temperature life (Preconditioning).	No damage.	PASSED			Accepted	
	Low level contact resistance.	30 mΩ max.	17.99	15.36	16.61	0.77	Accepted
	Vibration, random.	No discontinuities of 1 μs or longer duration.	PASSED			Accepted	
	Low level contact resistance.	30 mΩ max.	22.94 18.06 20.58 1.37				Accepted
	Examination of product.	Meets product drawing.	PASSED				Accepted

Figure 2 (Continued)

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Test				Test F			
Group	Test Description	Requirement	Max.	Min.	Ave.	Std. Dev.	Judgment
	Examination of product.	Meets product drawing.		PAS	SED		Accepted
	Dielectric withstanding voltage.	No breakdown or flashover.		Accepted			
	Insulation resistance.	1000 MΩ Min.		Accepted			
	Thermal shock.	No damage.		Accepted			
E	Humidity-temperature cycling.	No damage.	PASSED				Accepted
	Dielectric withstanding voltage.	No breakdown or flashover.	PASSED				Accepted
	Insulation resistance.	1000MΩ Min.	PASSED				Accepted
	Examination of product.	Meets product drawing.	PASSED			Accepted	
	Examination of product.	Meets product drawing.	PASSED			Accepted	
F	Solderability.	95% solder coverage min.	PASSED			Accepted	
	Examination of product.	Meets product drawing.	PASSED				Accepted
	Examination of product.	Meets product drawing.	PASSED				Accepted
G	Resistance to wave solder heat.	No damage. PASSED				Accepted	
	Examination of product.	Meets product drawing.		PAS	Accepted		
	Examination of product.	Meets product drawing.	PASSED			Accepted	
Н	Resistance to reflow solder heat.	No damage.	PASSED			Accepted	
	Examination of product.	Meets product drawing.		Accepted			
ı	Examination of product.	Meets product drawing.	PASSED			Accepted	
	Contact current rating/ Temperature rise.	Less than 30°C temp rise.	PASSED			Accepted	
	Examination of product.	Meets product drawing.	PASSED				Accepted

Figure 2 (End)

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